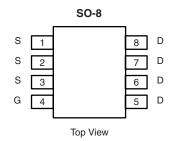




N-Channel 30-V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	$R_{DS(on)}\left(\Omega\right)$	I _D (A)	Q _g (Typ.)		
30	$0.0079 \text{ at V}_{GS} = 10 \text{ V}$	19.3 ^a	8.8 nC		
	0.010 at V _{GS} = 4.5 V	17.1 ^a	0.0110		



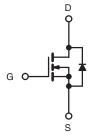
FEATURES

- Halogen-free
- TrenchFET® Power MOSFET
- 100 % R_g Tested
- 100 % UIS Tested

RoHS COMPLIANT

APPLICATIONS

- DC/DC
 - High Side
 - VRM
 - POL
 - Server



Ordering Information: Si4162DY-T1-GE3 (Lead (Pb)-free and Halogen-free)

N-Channel MOSFET

Parameter	Symbol	Limit	Unit		
Drain-Source Voltage	V _{DS}	30	V		
Gate-Source Voltage	V _{GS}	± 20			
	T _C = 25 °C		19.3 ^a		
Continuous Drain Current (T. 150 °C)	T _C = 70 °C		15.4		
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C	l _D	13.6 ^{b, c}		
	T _A = 70 °C	1	10.9 ^{b, c}	A	
Pulsed Drain Current		I _{DM}	70		
Avalanche Current	L = 0.1 mH	I _{AS}	31		
valanche Energy L = 0.1		E _{AS}	48	mJ	
Continuous Source-Drain Diode Current	T _C = 25 °C		4.2 ^a	^	
Continuous Source-Drain Diode Current	T _A = 25 °C	- I _S	2.1 ^{b, c}	A	
	T _C = 25 °C		5		
Maximum Daylar Dissination	T _C = 70 °C		3.2	w	
Maximum Power Dissipation	T _A = 25 °C	P _D	2.5 ^{b, c}	VV	
	T _A = 70 °C		1.6 ^{b, c}		
Operating Junction and Storage Temperature	T _J , T _{stg}	- 55 to 150	°C		
Soldering Recommendations (Peak Tempera		260			

THERMAL RESISTANCE RATINGS							
Parameter	Symbol	Typical	Maximum	Unit			
Maximum Junction-to-Ambient ^{b, d}	t ≤ 10 s	R _{thJA}	38	50	°C/W		
Maximum Junction-to-Case (Drain)	Steady State	R _{thJC}	20	25	J/ V V		

Notes

- a. Based on T_C = 25 °C.
- b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 10 s.
- d. Maximum under Steady State conditions is 85 $^{\circ}\text{C/W}.$

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Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static	-						
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	30			٧	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	J 050 A		32			
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA		- 5.5		mV/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$	1		3	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
		V _{DS} = 30 V, V _{GS} = 0 V	1		1	μΑ	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 30 V, V _{GS} = 0 V, T _J = 55 °C		5			
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	50			Α	
D : 0	Б	V _{GS} = 10 V, I _D = 20 A		0.0065	0.0079		
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = 4.5 V, I _D = 14 A		0.0082	0.010	Ω	
Forward Transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 20 A		70		S	
Dynamic ^b							
Input Capacitance	C _{iss}			1155			
Output Capacitance	C _{oss}	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		260		pF	
Reverse Transfer Capacitance	C _{rss}			95			
		$V_{DS} = 15 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 20 \text{ A}$		20	30	nC	
Total Gate Charge	Q _g V _{DS} = 10 V, V _{GS} = 10 V, I _D = 20 / V			8.8	14		
Gate-Source Charge	Q _{gs}	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 20 \text{ A}$		3.5			
Gate-Drain Charge	Q_{gd}			2.2			
Gate Resistance	R_{g}	f = 1 MHz		1.0	2.0	Ω	
Turn-On Delay Time	t _{d(on)}			20	30		
Rise Time	t _r	V_{DD} = 15 V, R_L = 15 Ω		15	25		
Turn-Off Delay Time	t _{d(off)}	$I_{D} \cong 1.0 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_{g} = 17 \Omega$		25	40		
Fall Time	t _f			10	15		
Turn-On Delay Time	t _{d(on)}			14	20	ns	
Rise Time	t _r	$V_{DD} = 15 \text{ V, R}_{L} = 15 \Omega$		9	15		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 1.0 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		25	40		
Fall Time	t _f			9	15		
Drain-Source Body Diode Characteristi	cs						
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			30	۸	
Pulse Diode Forward Current	I _{SM}				70	Α	
Body Diode Voltage	V _{SD}	I _S = 4.0 A, V _{GS} = 0 V		0.8	1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			21	42	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	L = 4.0.4 dl/dt = 100.4/vs T = 05.00		15	30	nC	
Reverse Recovery Fall Time	t _a	$I_F = 4.0 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		12.6			
Reverse Recovery Rise Time				8.4		ns	

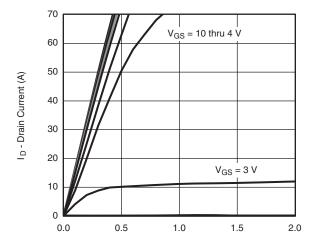
- a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



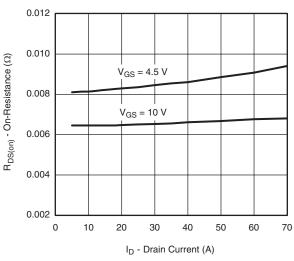


TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

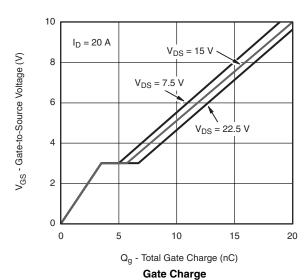


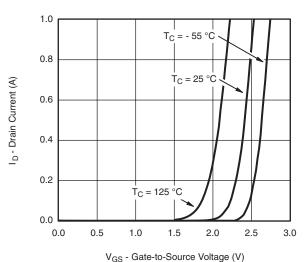
 V_{DS} - Drain-to-Source Voltage (V)

Output Characteristics

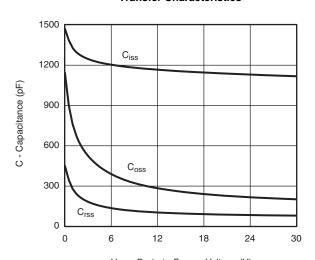


On-Resistance vs. Drain Current and Gate Voltage



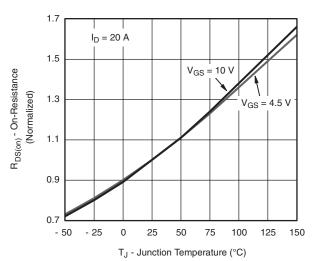


Transfer Characteristics



 $V_{\mbox{\footnotesize DS}}$ - Drain-to-Source Voltage (V)

Capacitance

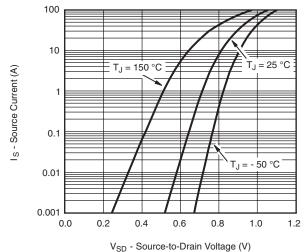


On-Resistance vs. Junction Temperature

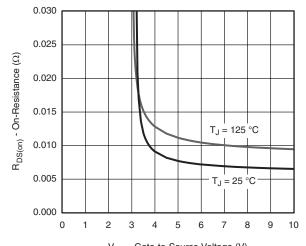
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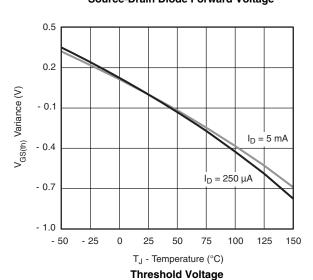
VISHAY

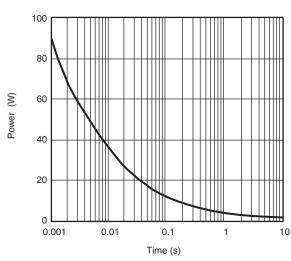
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



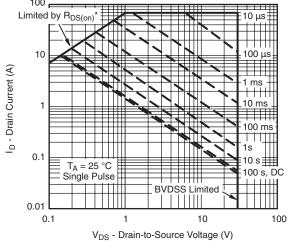
Source-Drain Diode Forward Voltage







Single Pulse Power (Junction-to-Ambient)

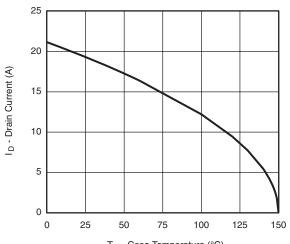


* V_{GS} > minimum V_{GS} at which R_{DS(on)} is specified

Safe Operating Area, Junction-to-Ambient

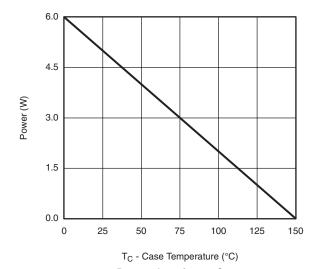


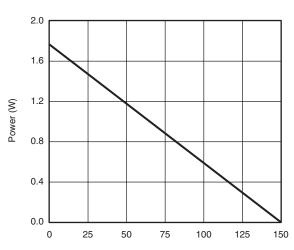
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



T_C - Case Temperature (°C)

Current Derating*





T_A - Ambient Temperature (°C)

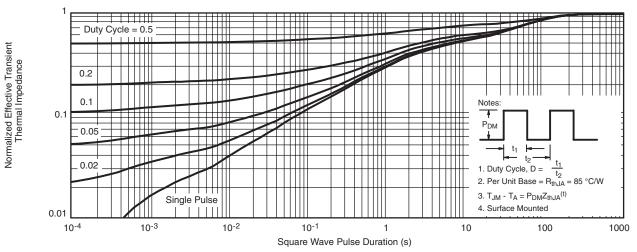
Power, Junction-to-Case Power, Junction-to-Ambient

^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

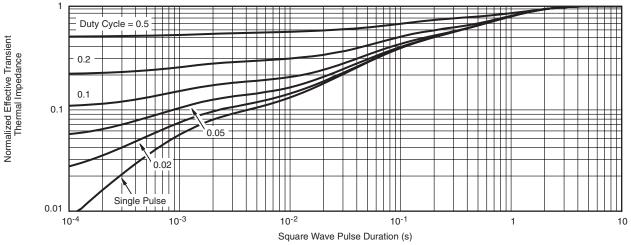
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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient



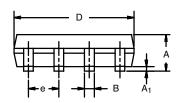
Normalized Thermal Transient Impedance, Junction-to-Foot

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see http://www.vishay.com/ppg?68967.



SOIC (NARROW): 8-LEAD JEDEC Part Number: MS-012







	MILLIM	IETERS	INC	HES		
DIM	Min	Max	Min	Max		
Α	1.35	1.75	0.053	0.069		
A ₁	0.10	0.20	0.004	0.008		
В	0.35	0.51	0.014	0.020		
С	0.19	0.25	0.0075	0.010		
D	4.80	5.00	0.189	0.196		
Е	3.80	4.00	0.150	0.157		
е	1.27	BSC	0.050	0.050 BSC		
Н	5.80	6.20	0.228	0.244		
h	0.25	0.50	0.010	0.020		
L	0.50	0.93	0.020	0.037		
q	0°	8°	0°	8°		
S	0.44	0.64	0.018	0.026		
FCN: C-06527-Rev 11-Sen-06						

ECN: C-06527-Rev. I, 11-Sep-06

DWG: 5498

Document Number: 71192 www.vishay.com 11-Sep-06 www.vishay.com



RECOMMENDED MINIMUM PADS FOR SO-8



Recommended Minimum Pads Dimensions in Inches/(mm)

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